

TDA8034T; TDA8034AT

Smart card interface

Rev. 01 — 5 February 2010

Product data sheet

1. General description

The TDA8034T/TDA8034AT is a cost-effective analog interface for asynchronous and synchronous smart cards operating at 5 V or 3 V. Using few external components, the TDA8034T/TDA8034AT provides all supply, protection and control functions between a smart card and the microcontroller.

2. Features

- Integrated circuit smart card interface in an SO16 package
- 5 V or 3 V smart card supply
- One protected half-duplex bidirectional buffered I/O line (C7)
- V_{CC} regulation:
 - ◆ $5\text{ V} \pm 5\%$ or $3\text{ V} \pm 5\%$ using two low ESR multilayer ceramic capacitors: one of 220 nF and one of 470 nF
 - ◆ current spikes of 40 nA/s ($V_{CC} = 5\text{ V}$ and 3 V) or 15 nA/s ($V_{CC} = 1.8\text{ V}$) up to 20 MHz, with controlled rise and fall times and filtered overload detection of approximately 120 mA
- Thermal and short-circuit protection for all card contacts
- Automatic activation and deactivation sequences triggered by a short-circuit, card take-off, overheating, falling V_{DD} , $V_{DD(\text{INTF})}$ or V_{DDP}
- Enhanced card-side ElectroStatic Discharge (ESD) protection of > 6 kV
- External clock input up to 26 MHz connected to pin XTAL1
- Card clock generation up to 20 MHz using pin CLKDIV1 with synchronous frequency changes of:
 - ◆ $\frac{1}{2} f_{\text{xtal}}$ or $\frac{1}{4} f_{\text{xtal}}$ on TDA8034T
 - ◆ f_{xtal} or $\frac{1}{2} f_{\text{xtal}}$ on TDA8034AT
- Non-inverted control of pin RST using pin RSTIN
- Compatible with ISO 7816, NDS and EMV 4.2 payment systems
- Supply supervisor for killing spikes during power on and off:
 - ◆ using a fixed threshold
 - ◆ using an external resistor bridge with threshold adjustment
- Built-in debouncing on card presence contacts (typically 4.5 ms)
- Multiplexed status signal using pin OFFN

3. Applications

- Pay TV
- Electronic payment

- Identification
- Bank card readers

4. Quick reference data

Table 1. Quick reference data

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|-----------------------------|---|------|-----|----------------|---------------|
| Supply | | | | | | |
| V_{DDP} | power supply voltage | pin V_{DDP} | 4.85 | 5 | 5.5 | V |
| V_{DD} | supply voltage | pin V_{DD} | 2.7 | 3.3 | 3.6 | V |
| $V_{DD(INTF)}$ | interface supply voltage | pin $V_{DD(INTF)}$ | 1.6 | 3.3 | $V_{DD} + 0.3$ | V |
| I_{DD} | supply current | Shutdown mode | - | - | 35 | μA |
| I_{DDP} | power supply current | Shutdown mode; f_{xtal} stopped | - | - | 5 | μA |
| | | Active mode; $f_{CLK} = \frac{1}{2} f_{xtal}$; no load | - | - | 1.5 | mA |
| $I_{DD(INTF)}$ | interface supply current | Shutdown mode | - | - | 6 | μA |
| Card supply voltage: pin V_{CC}^[1] | | | | | | |
| V_{CC} | supply voltage | active mode | | | | |
| | | 5 V card | | | | |
| | | $I_{CC} < 65\text{ mA DC}$ | 4.75 | 5.0 | 5.25 | V |
| | | current pulses of 40 nA/s at $I_{CC} < 200\text{ mA}$; $t < 400\text{ ns}$ | 4.65 | 5.0 | 5.25 | V |
| $V_{ripple(p-p)}$ | peak-to-peak ripple voltage | from 20 kHz to 200 MHz | - | - | 350 | mV |
| I_{CC} | supply current | $V_{CC} = 0\text{ V to } 5\text{ V or } 3\text{ V}$ | - | - | 65 | mA |
| General | | | | | | |
| t_{deact} | deactivation time | see Figure 7 on page 10 | 35 | 90 | 250 | μs |
| P_{tot} | total power dissipation | $T_{amb} = -25\text{ °C to } +85\text{ °C}$ | - | - | 0.25 | W |
| T_{amb} | ambient temperature | | -25 | - | +85 | °C |

[1] To meet these specifications, V_{CC} should be decoupled to pin GND using two ceramic multilayer capacitors of low ESR with values of either 100 nF or one 220 nF and one 470 nF.

5. Ordering information

Table 2. Ordering information

| Type number | Package | | Version |
|-------------|---------|--|----------|
| | Name | Description | |
| TDA8034T | SO16 | plastic small outline package; 16 leads; body width 3.9 mm | SOT109-1 |
| TDA8034AT | | | |

6. Block diagram

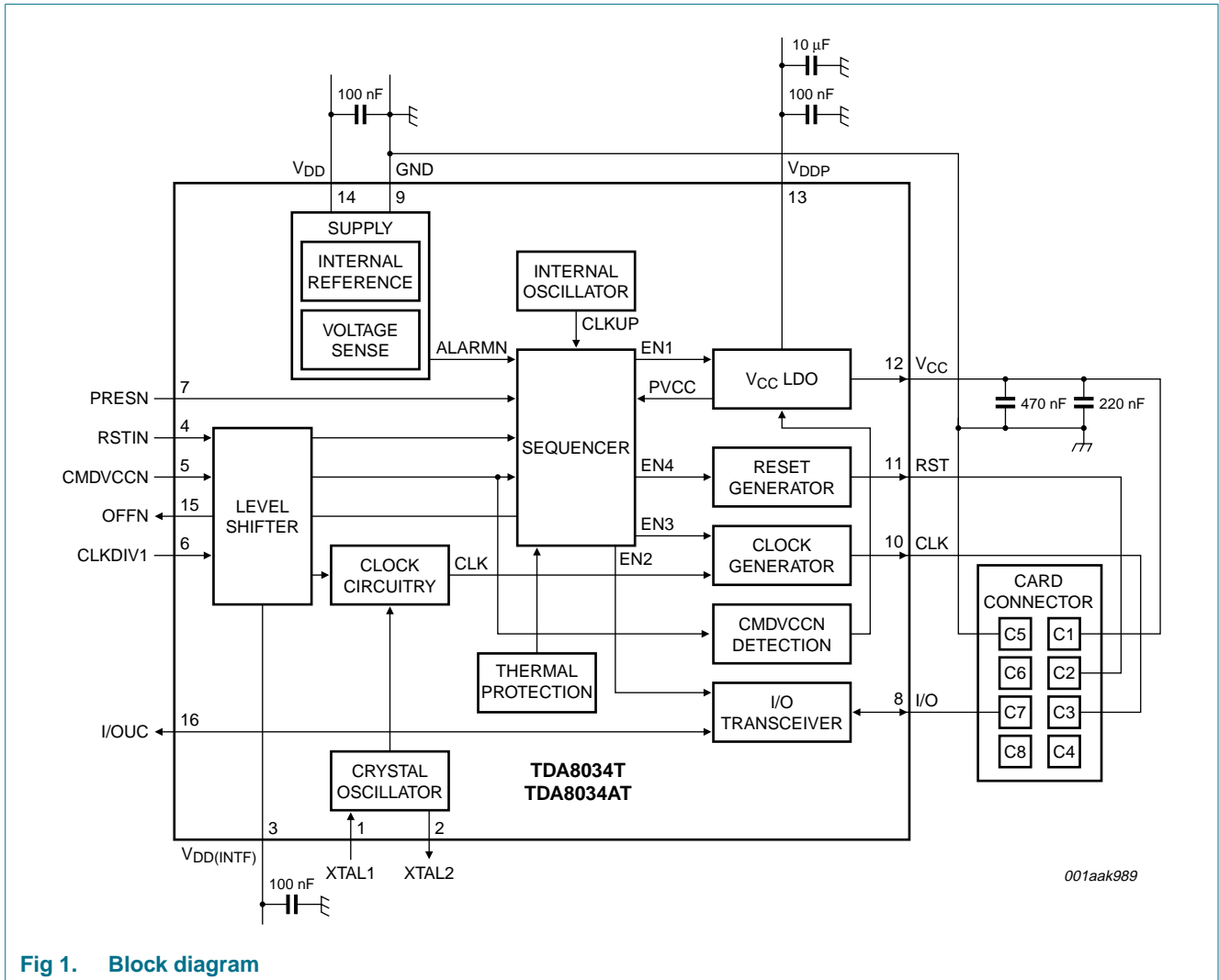


Fig 1. Block diagram

7. Pinning information

7.1 Pinning

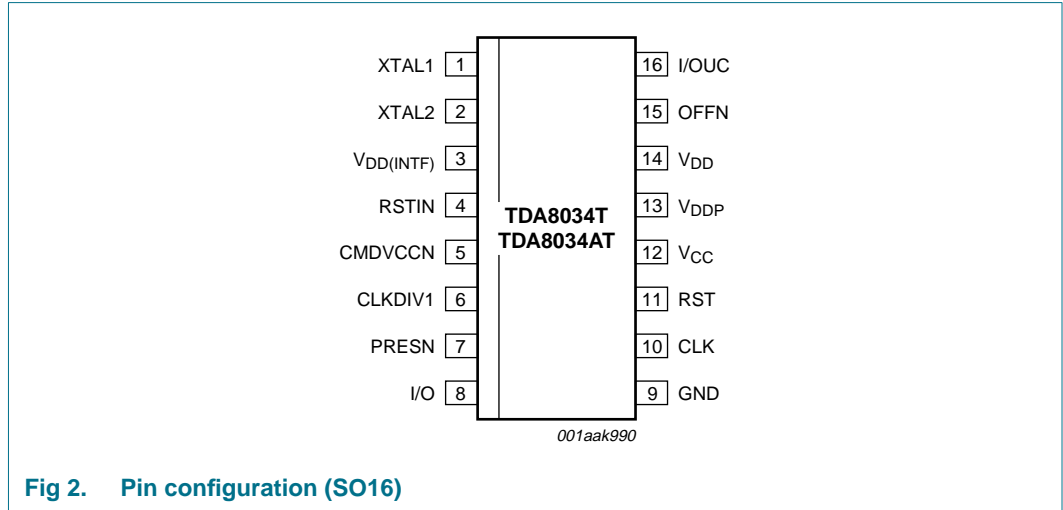


Fig 2. Pin configuration (SO16)

7.2 Pin description

Table 3. Pin description

| Symbol | Pin | Supply | Type ^[1] | Description |
|------------------------|-----|------------------------|---------------------|--|
| XTAL1 | 1 | V _{DD} | I | crystal connection input |
| XTAL2 | 2 | V _{DD} | O | crystal connection output |
| V _{DD} (INTF) | 3 | V _{DD} (INTF) | P | interface supply voltage |
| RSTIN | 4 | V _{DD} (INTF) | I | microcontroller card reset input; active HIGH |
| CMDVCCN | 5 | V _{DD} (INTF) | I | microcontroller start activation sequence input; active LOW |
| CLKDIV1 | 6 | V _{DD} (INTF) | I | sets the clock frequency on pin CLK; see Table 4 on page 7 |
| PRESN | 7 | V _{DD} (INTF) | I | card presence contact input; active LOW ^[2] |
| I/O | 8 | V _{CC} | I/O | card input/output data line (C7) ^[3] |
| GND | 9 | - | G | ground |
| CLK | 10 | V _{CC} | O | card clock (C3) |
| RST | 11 | V _{CC} | O | card reset (C2) |
| V _{CC} | 12 | V _{CC} | P | card supply (C1); decouple to pin GND using one 470 nF capacitor close to pin V _{CC} and one 220 nF capacitor close to card socket contact C1 with an ESR < 100 mΩ ^[4] |
| V _{DDP} | 13 | V _{DDP} | P | low-dropout regulator input supply voltage |
| V _{DD} | 14 | V _{DD} | P | digital supply voltage |
| OFFN | 15 | V _{DD} (INTF) | O | NMOS interrupt to microcontroller ^[5] ; active LOW; see Section 8.9 on page 10 |
| I/OUC | 16 | V _{DD} (INTF) | I/O | microcontroller input/output data line ^[3] |

[1] I = input, O = output, I/O = input/output, G = ground and P = power supply.

[2] If pin PRESN is HIGH, the card is considered to be present. During card insertion, debouncing can occur on these signals. To counter this, the TDA8034T/TDA8034AT has a built-in debouncing timer (typically 4.5 ms).

[3] Uses an internal 11 kΩ pull-up resistor connected to pin V_{CC}.

[4] Using a 220 nF capacitor increases the noise margin on pin V_{CC}.

[5] Uses an internal 20 kΩ pull-up resistor connected to pin V_{DD}.

8. Functional description

Remark: Throughout this document the ISO 7816 terminology conventions have been adhered to and it is assumed that the reader is familiar with these.

8.1 Power supplies

The power supply voltage ranges are as follows:

- V_{DDP}: 4.85 V to 5.5 V
- V_{DD}: 2.7 V to 3.6 V

All interface signals to the system controller are referenced to V_{DD(INTF)}. All card contacts remain inactive during power up or power down. After powering up the device, pin OFFN remains LOW until pin CMDVCCN is set HIGH and pin PRESN is LOW. During power down, pin OFFN goes LOW when V_{DDP} falls below the falling threshold voltage (V_{th}).

The internal oscillator frequency (f_{osc(int)}) is only used during the activation sequences. When the card is not activated (pin CMDVCCN is HIGH), the internal oscillator is in low frequency mode to reduce power consumption.

This device has a Low Drop-Off (LDO) voltage regulator connected to pin V_{CC}, and is used instead of a DC-to-DC converter. It ensures a minimum V_{CC} of 4.75 V and that the power supply voltage on pin V_{DDP} does not fall below 4.85 V for a maximum load current of 65 mA.

8.2 Voltage supervisor circuit

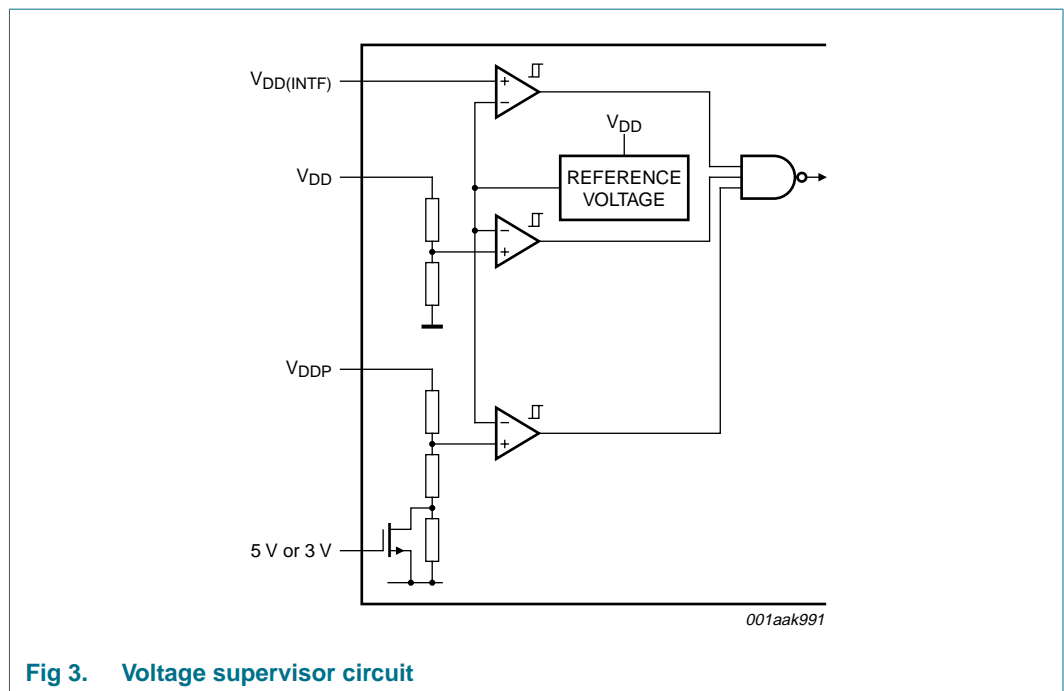


Fig 3. Voltage supervisor circuit

The voltage supervisor monitors the voltage of the V_{DDP} and V_{DD} supplies providing both Power-On Reset (POR) and supply drop-out detection during a card session. The supervisor threshold voltages for V_{DDP} and V_{DD} are set internally. As long as V_{DD} is less than $V_{th} + V_{hys}$, the IC remains inactive irrespective of the command line levels. After V_{DD} has reached a level higher than $V_{th} + V_{hys}$, the IC remains inactive for the duration of t_w . The output of the supervisor is sent to a digital controller in order to reset the TDA8034T/TDA8034AT. This defined reset pulse of approximately 8 ms, i.e. ($t_w = 1024 \times \frac{1}{f_{osc(int)low}}$), is used internally to maintain the IC in the Shutdown mode during the supply voltage power on; see [Figure 4](#). A deactivation sequence is performed when either V_{DD} or V_{DDP} falls below V_{th} .

Remark: $f_{osc(int)low}$ is the low frequency (or inactive) mode of the defined $f_{osc(int)}$ parameter.

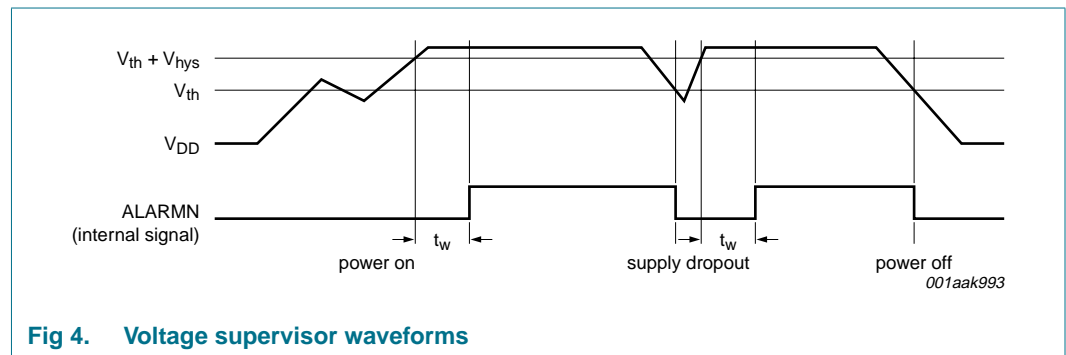
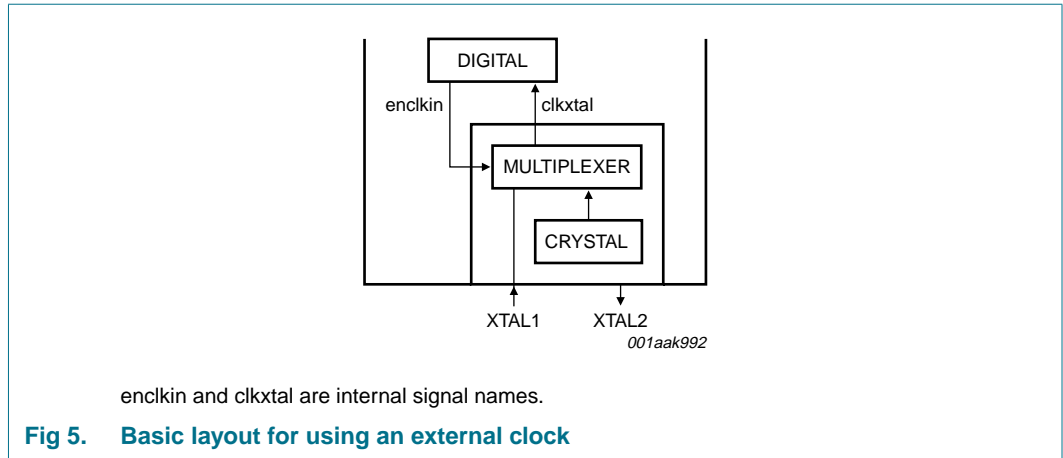


Fig 4. Voltage supervisor waveforms

8.3 Clock circuits

The clock signal from pin CLK to the card is either supplied by an external clock signal connected to pin XTAL1 or generated using a crystal connected between pins XTAL1 and XTAL2. The TDA8034T/TDA8034AT automatically detects if an external clock is connected to XTAL1, eliminating the need for a separate pin to select the clock source.

Automatic clock source detection is performed on each activation command (falling edge of the signal on pin CMDVCCN). The presence of an external clock on pin XTAL1 is checked during a time window defined by the internal oscillator. If a clock is detected, the internal crystal oscillator is stopped. If a clock is not detected, the internal crystal oscillator is started. When an external clock is used, it is mandatory that the clock is applied to pin XTAL1 before the falling edge of the signal on pin CMDVCCN.



The clock frequency is selected using pin CLKDIV1 to be either $\frac{1}{2} f_{xtal}$ or $\frac{1}{4} f_{xtal}$ on TDA8034T or f_{xtal} or $\frac{1}{2} f_{xtal}$ on TDA8034AT as shown in [Table 4](#).

The frequency change is synchronous and as such during transition, no pulse is shorter than 45 % of the smallest period. In addition, only the first and last clock pulse around the change has the correct width. When dynamically changing the frequency, the modification is only effective after 10 clock periods on pin XTAL1.

The duty cycle of f_{xtal} on pin CLK should be between 45 % and 55 %. If an external clock is connected to pin XTAL1, its duty cycle must be between 48 % and 52 %.

When the frequency of the clock signal on pin CLK is either $\frac{1}{2} f_{xtal}$ or $\frac{1}{4} f_{xtal}$ on TDA8034T or f_{xtal} or $\frac{1}{2} f_{xtal}$ on TDA8034AT, the frequency dividers guarantee a duty cycle between 45 % and 55 %.

Table 4. Clock configuration

| Pin CLKDIV1 level | Pin CLK level | |
|-------------------|------------------------|------------------------|
| | TDA8034T | TDA8034AT |
| HIGH | $\frac{1}{2} f_{xtal}$ | $\frac{1}{2} f_{xtal}$ |
| LOW | $\frac{1}{4} f_{xtal}$ | f_{xtal} |

8.4 Input and output circuits

When pins I/O and I/OUC are pulled HIGH using an 11 kΩ resistor between pins I/O and V_{CC} and/or between pins I/OUC and V_{DD(INTF)}, both lines enter the idle state. Pin I/O is referenced to V_{CC} and pin I/OUC to V_{DD(INTF)}, thus allowing operation at V_{CC} ≠ V_{DD(INTF)}.

The first side on which a falling edge occurs becomes the master. An anti-latch circuit disables falling edge detection on the other line, making it the slave. After a time delay t_d, the logic 0 present on the master-side is sent to the slave-side. When the master-side returns logic 1, the slave-side sends logic 1 during time delay (t_{w(pu)}). After this sequence, both master and slave sides return to their idle states.

The active pull-up feature ensures fast LOW-to-HIGH transitions making the TDA8034T/TDA8034AT capable of delivering more than 1 mA, up to an output voltage of 0.9V_{CC}, at a load of 80 pF. At the end of the active pull-up pulse, the output voltage is dependent on the internal pull-up resistor value and load current. The current sent to and received from the card's I/O lines is limited to 15 mA at a maximum frequency of 1 MHz.

8.5 Shutdown mode

After a power-on reset, if pin CMDVCCN is HIGH, the circuit enters the Shutdown mode, ensuring only the minimum number of circuits are active while the TDA8034T/TDA8034AT waits for the microcontroller to start a session.

- all card contacts are inactive. The impedance between the contacts and GND is approximately 200 Ω .
- pin I/OUC is high-impedance using the 11 k Ω pull-up resistor connected to $V_{DD(INTF)}$
- the voltage generators are stopped
- the voltage supervisor is active
- the internal oscillator runs at its lowest frequency ($f_{osc(int)low}$)

8.6 Activation sequence

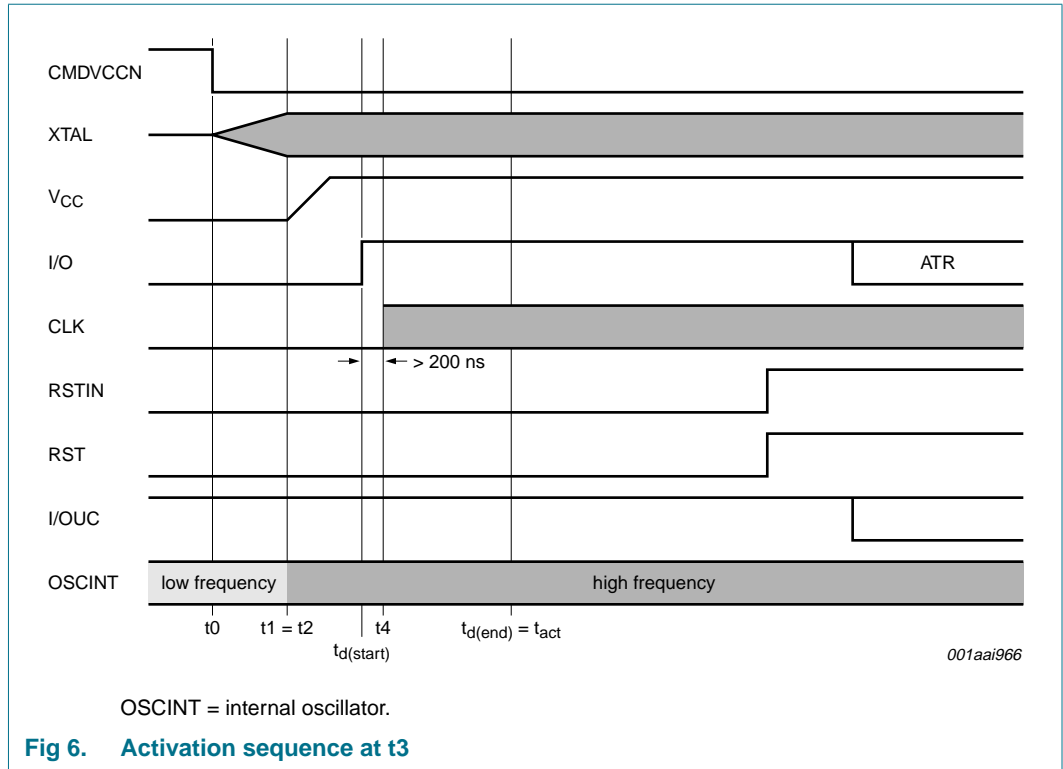
The following device activation sequence is applied when using an external clock; see [Figure 6](#):

1. Pin CMDVCCN is pulled LOW (t_0).
2. The internal oscillator is triggered (t_0).
3. The internal oscillator changes to high frequency (t_1).
4. V_{CC} rises from either 0 V to 3 V or 0 V to 5 V on a controlled slope (t_2).
5. Pin I/O is driven HIGH (t_3).
6. The clock on pin CLK is applied to the C3 contact (t_4).
7. Pin RST is enabled (t_5).

Calculation of the time delays is as follows:

- $t_1 = t_0 + 384 \times \frac{1}{f_{osc(int)low}}$
- $t_2 = t_1$
- $t_3 = t_1 + 17T / 2$
- $t_4 =$ driven by host controller; $> t_3$ and $< t_5$
- $t_5 = t_1 + 23T / 2$

Remark: The value of period T is 64 times the period interval of the internal oscillator at high frequency ($\frac{1}{f_{osc(int)high}}$); t_3 is called $t_{d(start)}$ and t_5 is called $t_{d(end)}$.



8.7 Deactivation sequence

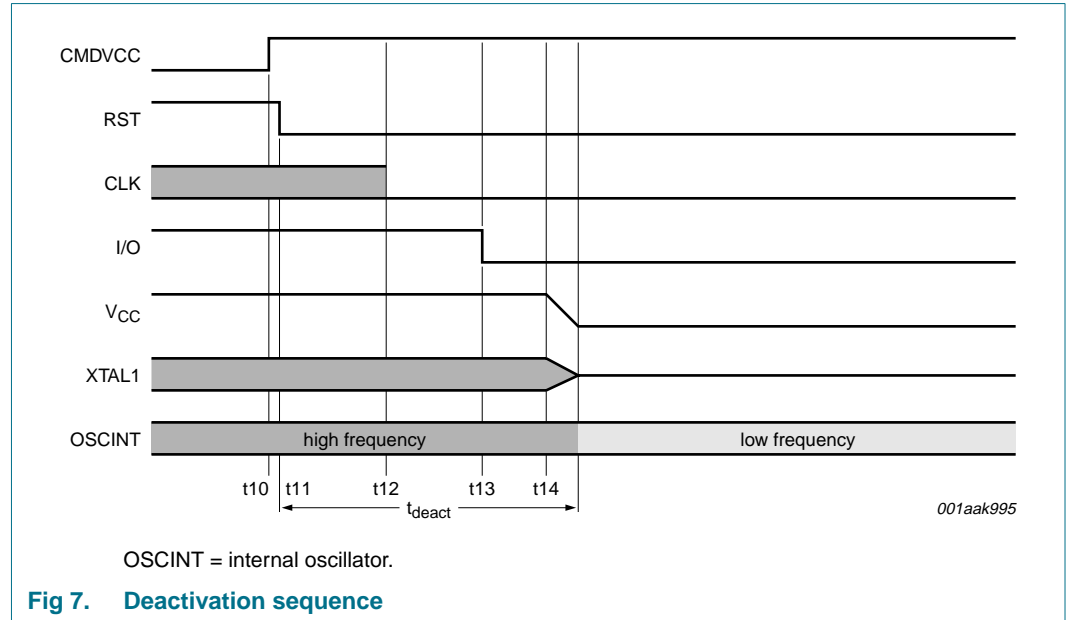
When a session ends, the microcontroller sets pin CMDVCCN HIGH. The TDA8034T/TDA8034AT then executes an automatic deactivation sequence by counting the sequencer back to the inactive state (see [Figure 7](#)) as follows:

1. Pin RST is pulled LOW (t11).
2. The clock is stopped, pin CLK is LOW (t12).
3. Pin I/O is pulled LOW (t13).
4. V_{CC} falls to 0 V (t14). The deactivation sequence is completed when V_{CC} reaches its inactive state.
5. V_{CC} < 0.4 V (t_{deac})
6. All card contacts become low-impedance to GND. However, pin I/OUC remains pulled up to V_{DD} using the 11 kΩ resistor.
7. The internal oscillator returns to its low frequency mode.

Calculation of the time delays is as follows:

- $t_{11} = t_{10} + 3T / 64$
- $t_{12} = t_{11} + T / 2$
- $t_{13} = t_{11} + T$
- $t_{14} = t_{11} + 3T / 2$
- $t_{deac} = t_{11} + 3T / 2 + V_{CC} \text{ fall time}$

Remark: The value of period T is 64 times the period interval of the internal oscillator (i.e. $\pm 25 \mu\text{s}$).



8.8 V_{CC} regulator

The V_{CC} buffer is able to continuously deliver up to 65 mA at V_{CC} = 5 V or 3 V.

The V_{CC} buffer has an internal overload protection with a threshold value of approximately 120 mA. This detection is internally filtered, enabling spurious current pulses up to 200 mA with a duration of a few milliseconds to be drawn by the card without causing deactivation. However, the average current value must stay below maximum; see [Table 8](#).

8.9 Fault detection

The following conditions are monitored by the fault detection circuit:

- Short-circuit or high current on pin V_{CC}
- Card removal during transaction
- V_{DDP} falling
- V_{DD} falling
- V_{DD(INTF)} falling
- Overheating

Fault detection monitors two different situations:

- Outside card sessions, pin CMDVCCN is HIGH: pin OFFN is LOW if the card is not in the reader and HIGH if the card is in the reader. Any voltage drop on V_{DD} is detected by the voltage supervisor. This generates an internal power-on reset pulse but does not act upon the pin OFFN signal. The card is not powered-up and short-circuits or overheating are not detected.

- In card sessions, pin CMDVCCN is LOW: when pin OFFN goes LOW, the fault detection circuit triggers the automatic emergency deactivation sequence (see [Figure 8](#)). When the microcontroller resets pin CMDVCCN to HIGH, after the deactivation sequence, pin OFFN is rechecked. If the card is still present, pin OFFN returns to HIGH. This check identifies the fault as either a hardware problem or a card removal incident.

On card insertion or removal, bouncing can occur in the PRESN signal. This depends on the type of card presence switch in the connector (normally open or normally closed) and the mechanical characteristics of the switch. To correct for this, a debouncing feature is integrated in to the TDA8034T/TDA8034AT. This feature operates at a typical duration of 4.5 ms ($t_{deb} = 640 \times (1/f_{osc(int)low})$). [Figure 9 on page 12](#) shows the operation of the debouncing feature.

On card insertion, pin OFFN goes HIGH after the debounce time has elapsed. When the card is extracted, the automatic card deactivation sequence is performed on the first HIGH/LOW transition on pin PRESN. After this, pin OFFN goes LOW.

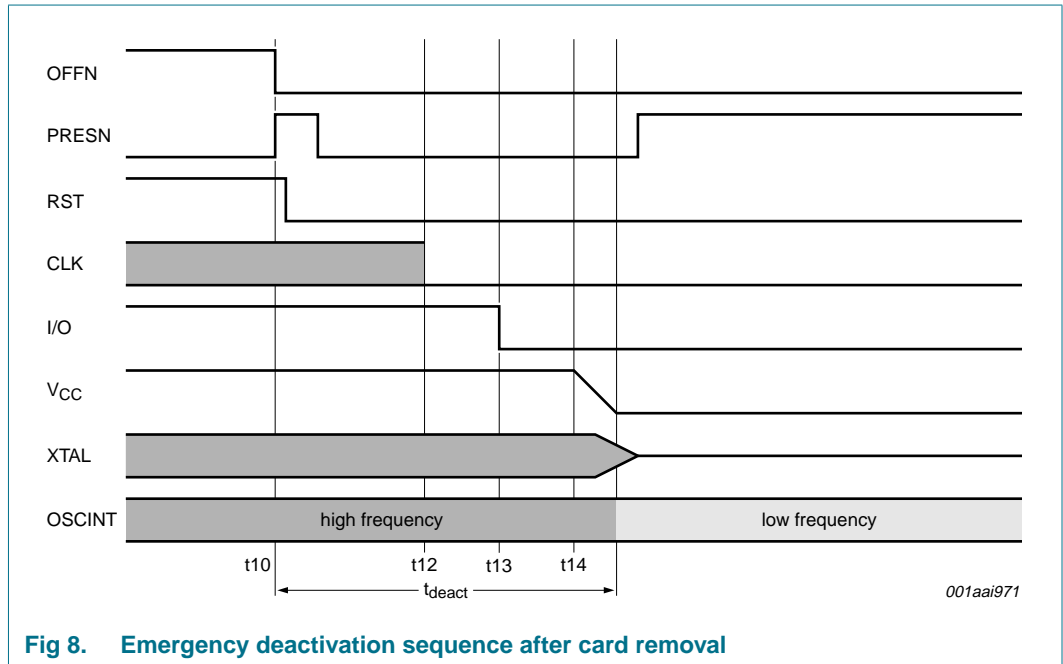
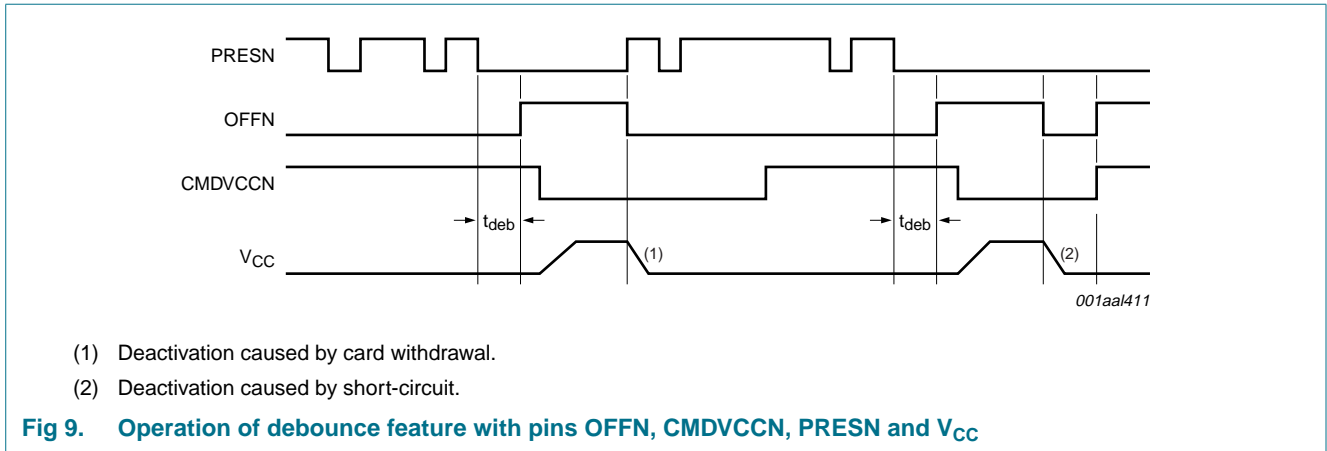


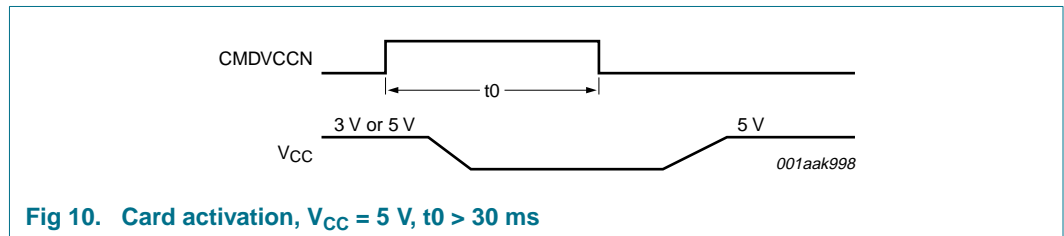
Fig 8. Emergency deactivation sequence after card removal



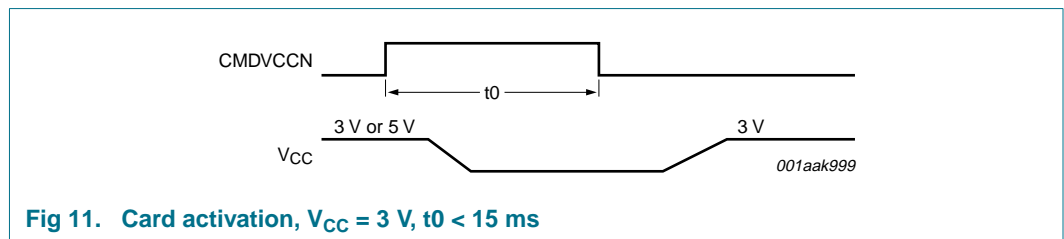
8.10 Automatic determining of card supply voltage

The supply voltage (V_{CC}) that the card requires is determined automatically by monitoring the duration of the HIGH state (logic 1) on pin CMDVCCN before the activation command (CMDVCCN falling edge) occurs. If pin CMDVCCN stays HIGH for more than 30 ms, activation occurs with V_{CC} set to 5 V. If pin CMDVCCN stays HIGH for less than 15 ms, activation occurs with V_{CC} set to 3 V.

To activate the card at $V_{CC} = 5$ V, pin CMDVCCN must stay HIGH for $t_0 > 30$ ms before going LOW (logic 0).



To activate the card at $V_{CC} = 3$ V, pin CMDVCCN must stay HIGH for $t_0 < 15$ ms before going LOW (logic 0).



If pin CMDVCCN is HIGH for more than 15 ms ($t_0 > 15$ ms) but less than 30 ms, pin CMDVCCN must be set LOW for t_1 ($200 \mu s < t_1 < 700 \mu s$), and then HIGH for t_2 ($200 \mu s < t_2 < 15$ ms) before going LOW.

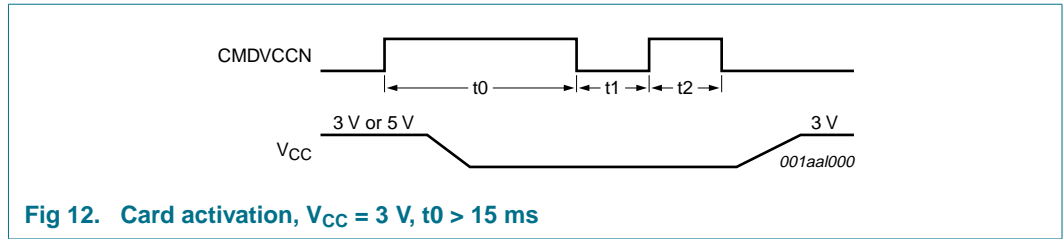


Fig 12. Card activation, V_{CC} = 3 V, t₀ > 15 ms

If pin CMDVCCN is HIGH for more than 30 ms (card inactive), and if the card needs to be activated at 3 V, the sequence shown in Figure 12 applies: pin CMDVCCN must be set LOW for t₁ (200 μs < t₁ < 700 μs), and then HIGH for t₂ (200 μs < t₂ < 15 ms) before going LOW.

9. Limiting values

Remark: All card contacts are protected against any short-circuit to any other card contact. Stress beyond the levels indicated in Table 5 can cause permanent damage to the device. This is a short-term stress rating only and under no circumstances implies functional operation under long-term stress conditions.

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-----------------------|---------------------------------|--|------|------|------|
| V _{DDP} | power supply voltage | pin V _{DDP} | -0.3 | +6 | V |
| V _{DD} | supply voltage | pin V _{DD} | -0.3 | +4.6 | V |
| V _{DD(INTF)} | interface supply voltage | pin V _{DD(INTF)} | -0.3 | +4.6 | V |
| V _i | input voltage | pins CMDVCCN, CLKDIV1, RSTIN, OFFN, XTAL1, XTAL2, I/OUC | -0.3 | +4.6 | V |
| | | card contact pins PRESN, I/O, RST and CLK | -0.3 | +6 | V |
| T _{stg} | storage temperature | | -55 | +150 | °C |
| P _{tot} | total power dissipation | T _{amb} = -25 °C to +85 °C | - | 0.25 | W |
| T _j | junction temperature | | - | +125 | °C |
| T _{amb} | ambient temperature | | -25 | +85 | °C |
| V _{ESD} | electrostatic discharge voltage | Human Body Model (HBM) on card pins I/O, RST, V _{CC} , CLK, PRESN; within typical application | -6 | +6 | kV |
| | | Human Body Model (HBM); all other pins | -2 | +2 | kV |
| | | Machine Model (MM); all pins | -200 | +200 | V |
| | | Field Charged Device Model (FCDM); all pins | -500 | +500 | V |

10. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Package name | Parameter | Conditions | Typ | Unit |
|----------------------|--------------|---|-------------|-----|------|
| R _{th(j-a)} | SO16 | thermal resistance from junction to ambient | in free air | 94 | K/W |

11. Characteristics

Table 7. Characteristics of IC supply voltage

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|-----------------------------|---|--------------------|-------|----------------|------------------|
| Supply | | | | | | |
| V_{DDP} | power supply voltage | pin V_{DDP} | 4.85 | 5 | 5.5 | V |
| V_{DD} | supply voltage | pin V_{DD} | 2.7 | 3.3 | 3.6 | V |
| $V_{DD(INTF)}$ | interface supply voltage | pin $V_{DD(INTF)}$ | 1.6 | 3.3 | $V_{DD} + 0.3$ | V |
| I_{DD} | supply current | Shutdown mode | - | - | 35 | μA |
| I_{DDP} | power supply current | Shutdown mode | | | | |
| | | f_{xtal} stopped | - | - | 5 | μA |
| | | Active mode | | | | |
| | | $f_{CLK} = \frac{1}{2} f_{xtal}$; no load | - | - | 1.5 | mA |
| | | $f_{CLK} = \frac{1}{2} f_{xtal}$; $I_{CC} = 65\text{ mA}$ | - | - | 70 | mA |
| $I_{DD(INTF)}$ | interface supply current | Shutdown mode | - | - | 6 | μA |
| V_{th} | threshold voltage | pin V_{DD} | 2.30 | 2.40 | 2.50 | V |
| | | pin V_{DDP} | 3.00 | 4.10 | 4.40 | V |
| V_{hys} | hysteresis voltage | pin V_{DD} | 50 | 100 | 150 | mV |
| | | pin V_{DDP} | 100 | 200 | 350 | mV |
| t_w | pulse width | | 5.1 | 8 | 10.2 | ms |
| Card supply voltage: pin V_{CC}^[1] | | | | | | |
| C_{dec} | decoupling capacitance | connected to V_{CC} | ^[2] 550 | - | 830 | nF |
| V_o | output voltage | Shutdown mode | | | | |
| | | no load | -0.1 | - | +0.1 | V |
| | | $I_o = 1\text{ mA}$ | -0.1 | - | +0.3 | V |
| I_o | output current | Shutdown mode; pin V_{CC} connected to ground | - | - | -1 | mA |
| V_{CC} | supply voltage | active mode | | | | |
| | | 5 V card | | | | |
| | | $I_{CC} < 65\text{ mA DC}$ | 4.75 | 5.0 | 5.25 | V |
| | | current pulses of 40 nA/s at $I_{CC} < 200\text{ mA}$; $t < 400\text{ ns}$ | 4.65 | 5.0 | 5.25 | V |
| | | 3 V card | | | | |
| | | $I_{CC} < 65\text{ mA DC}$ | 2.85 | 3.05 | 3.15 | V |
| | | current pulses of 40 nA/s at $I_{CC} < 200\text{ mA}$; $t < 400\text{ ns}$ | 2.76 | - | 3.20 | V |
| $V_{ripple(p-p)}$ | peak-to-peak ripple voltage | 20 kHz to 200 MHz | - | - | 350 | mV |
| I_{CC} | supply current | $V_{CC} = 0\text{ V to } 5\text{ V or } 3\text{ V}$ | - | - | 65 | mA |
| | | V_{CC} shorted to ground | 90 | 120 | 150 | mA |
| SR | slew rate | 5 V card | 0.055 | 0.180 | 0.300 | V/ μs |
| | | 3 V card | 0.040 | 0.180 | 0.300 | V/ μs |

Table 7. Characteristics of IC supply voltage ...continued

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|---------------------------|--|--------------------|-----|----------------------|---------------|
| Crystal oscillator: pins XTAL1 and XTAL2 | | | | | | |
| C_{ext} | external capacitance | pins XTAL1 and XTAL2 (depending on the crystal or resonator specification) | - | - | 15 | pF |
| f_{xtal} | crystal frequency | card clock reference; crystal oscillator | 2 | - | 26 | MHz |
| f_{ext} | external frequency | external clock on pin XTAL1 | 0 | - | 26 | MHz |
| V_{IL} | LOW-level input voltage | crystal oscillator | -0.3 | - | +0.3 V_{DD} | V |
| | | external clock | -0.3 | - | +0.3 $V_{DD(INTF)}$ | V |
| V_{IH} | HIGH-level input voltage | crystal oscillator | 0.7 V_{DD} | - | $V_{DD} + 0.3$ | V |
| | | external clock | 0.7 $V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.3$ | V |
| Data lines: pins I/O and I/OC | | | | | | |
| t_d | delay time | falling edge on pins I/O and I/OC or vice versa | - | - | 200 | ns |
| $t_{w(pu)}$ | pull-up pulse width | | 200 | - | 400 | ns |
| f_{io} | input/output frequency | on data lines | - | - | 1 | MHz |
| C_i | input capacitance | on data lines | - | - | 10 | pF |
| Data lines to the card: pin I/O³ | | | | | | |
| V_o | output voltage | Shutdown mode | | | | |
| | | no load | 0 | - | 0.1 | V |
| | | $I_o = 1\text{ mA}$ | 0 | - | 0.3 | V |
| I_o | output current | Shutdown mode; pin I/O grounded | - | - | -1 | mA |
| V_{OL} | LOW-level output voltage | $I_{OL} = 1\text{ mA}$ | 0 | - | 0.3 | V |
| | | $I_{OL} \geq 15\text{ mA}$ | $V_{CC} - 0.4$ | - | V_{CC} | V |
| V_{OH} | HIGH-level output voltage | no DC load | 0.9 V_{CC} | - | $V_{CC} + 0.1$ | V |
| | | $I_{OH} < -40\text{ }\mu\text{A}$ | 0.75 V_{CC} | - | $V_{CC} + 0.1$ | V |
| | | $I_{OH} \geq -15\text{ mA}$ | 0 | - | 0.4 | V |
| V_{IL} | LOW-level input voltage | | -0.3 | - | +0.8 | V |
| V_{IH} | HIGH-level input voltage | $V_{CC} = +5\text{ V}$ | 0.6 V_{CC} | - | $V_{CC} + 0.3$ | V |
| | | $V_{CC} = +3\text{ V}$ | 0.7 V_{CC} | - | $V_{CC} + 0.3$ | V |
| V_{hys} | hysteresis voltage | pin I/O | - | 50 | - | mV |
| I_{IL} | LOW-level input current | pin I/O; $V_{IL} = 0\text{ V}$ | - | - | 600 | μA |
| I_{IH} | HIGH-level input current | pin I/O; $V_{IH} = V_{CC}$ | - | - | 10 | μA |
| $t_{r(i)}$ | input rise time | V_{IL} maximum to V_{IH} minimum | - | - | 1.2 | μs |
| $t_{r(o)}$ | output rise time | $C_L \leq 80\text{ pF}$; 10 % to 90 %; 0 V to V_{CC} | - | - | 0.1 | μs |
| $t_{f(i)}$ | input fall time | V_{IL} maximum to V_{IH} minimum | - | - | 1.2 | μs |
| $t_{f(o)}$ | output fall time | $C_L \leq 80\text{ pF}$; 10 % to 90 %; 0 V to V_{CC} | - | - | 0.1 | μs |

Table 7. Characteristics of IC supply voltage ...continued

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|-------------------------------|---|--------------------|--------------------|----------------------|---------------|
| R_{pu} | pull-up resistance | connected to V_{CC} | 7 | 9 | 11 | $k\Omega$ |
| I_{pu} | pull-up current | $V_{OH} = 0.9V_{CC}$; $C = 80\text{ pF}$ | -8 | -6 | -4 | mA |
| Data lines to the system: pin I/OUC^[4] | | | | | | |
| V_{OL} | LOW-level output voltage | $I_{OL} = 1\text{ mA}$ | 0 | - | 0.3 | V |
| V_{OH} | HIGH-level output voltage | no DC load | $0.9V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.1$ | V |
| | | $I_{OH} \leq 40\text{ }\mu\text{A}$; $V_{DD(INTF)} > 2\text{ V}$ | $0.75V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.1$ | V |
| | | $I_{OH} \leq 20\text{ }\mu\text{A}$; $V_{DD(INTF)} < 2\text{ V}$ | $0.75V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.1$ | V |
| V_{IL} | LOW-level input voltage | | -0.3 | - | $+0.3V_{DD(INTF)}$ | V |
| V_{IH} | HIGH-level input voltage | | $0.7V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.3$ | V |
| V_{hys} | hysteresis voltage | pin I/OUC | - | $0.14V_{DD(INTF)}$ | - | V |
| I_{IH} | HIGH-level input current | $V_{IH} = V_{DD(INTF)}$ | - | - | 10 | μA |
| I_{IL} | LOW-level input current | $V_{IL} = 0\text{ V}$ | - | - | 600 | μA |
| R_{pu} | pull-up resistance | connected to $V_{DD(INTF)}$ | 8 | 10 | 12 | $k\Omega$ |
| $t_{r(i)}$ | input rise time | V_{IL} maximum to V_{IH} minimum | - | - | 1.2 | μs |
| $t_{r(o)}$ | output rise time | $C_L \leq 30\text{ pF}$; 10 % to 90 %; 0 V to $V_{DD(INTF)}$ | - | - | 0.1 | μs |
| $t_{f(i)}$ | input fall time | V_{IL} maximum to V_{IH} minimum | - | - | 1.2 | μs |
| $t_{f(o)}$ | output fall time | $C_L \leq 30\text{ pF}$; 10 % to 90 %; 0 V to $V_{DD(INTF)}$ | - | - | 0.1 | μs |
| I_{pu} | pull-up current | $V_{OH} = 0.9V_{DD}$; $C = 30\text{ pF}$ | -1 | - | - | mA |
| Internal oscillator | | | | | | |
| $f_{osc(int)}$ | internal oscillator frequency | Shutdown mode | 100 | 150 | 200 | kHz |
| | | active state | 2 | 2.7 | 3.2 | MHz |
| Reset output to the card: pin RST | | | | | | |
| V_o | output voltage | Shutdown mode | | | | |
| | | no load | 0 | - | 0.1 | V |
| | | $I_o = 1\text{ mA}$ | 0 | - | 0.3 | V |
| I_o | output current | Shutdown mode; pin RST grounded | - | - | -1 | mA |
| t_d | delay time | between pins RSTIN and RST; RST enabled | - | - | 2 | μs |
| V_{OL} | LOW-level output voltage | $I_{OL} = 200\text{ }\mu\text{A}$; $V_{CC} = +5\text{ V}$ | 0 | - | 0.3 | V |
| | | $I_{OL} = 200\text{ }\mu\text{A}$; $V_{CC} = +3\text{ V}$ | 0 | - | 0.2 | V |
| | | current limit $I_{OL} = 20\text{ mA}$ | $V_{CC} - 0.4$ | - | V_{CC} | V |
| V_{OH} | HIGH-level output voltage | $I_{OH} = -200\text{ }\mu\text{A}$ | $0.9V_{CC}$ | - | V_{CC} | V |
| | | current limit $I_{OH} = -20\text{ mA}$ | 0 | - | 0.4 | V |
| t_r | rise time | $C_L = 100\text{ pF}$ | - | - | 0.1 | μs |

Table 7. Characteristics of IC supply voltage ...continued

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|---------------------------|--|-------------------|--------------------|----------------------|---------------|
| t_f | fall time | $C_L = 100\text{ pF}$ | - | - | 0.1 | μs |
| Clock output to the card: pin CLK | | | | | | |
| V_o | output voltage | Shutdown mode | | | | |
| | | no load | 0 | - | 0.1 | V |
| | | $I_o = 1\text{ mA}$ | 0 | - | 0.3 | V |
| I_o | output current | Shutdown mode; pin CLK grounded | - | - | -1 | mA |
| V_{OL} | LOW-level output voltage | $I_{OL} = 200\text{ }\mu\text{A}$ | 0 | - | 0.3 | V |
| | | current limit $I_{OL} = 70\text{ mA}$ | $V_{CC} - 0.4$ | - | V_{CC} | V |
| V_{OH} | HIGH-level output voltage | $I_{OH} = -200\text{ }\mu\text{A}$ | $0.9V_{CC}$ | - | V_{CC} | V |
| | | current limit $I_{OH} = -70\text{ mA}$ | 0 | - | 0.4 | V |
| t_r | rise time | $C_L = 30\text{ pF}$ | [5] | - | 16 | ns |
| t_f | fall time | $C_L = 30\text{ pF}$ | [5] | - | 16 | ns |
| f_{CLK} | frequency on pin CLK | operational | 0 | - | 20 | MHz |
| δ | duty cycle | $C_L = 30\text{ pF}$ | [5] | 45 | 55 | % |
| SR | slew rate | rise and fall; $C_L = 30\text{ pF}$ | | | | |
| | | $V_{CC} = +5\text{ V}$ | 0.2 | - | - | V/ns |
| | | $V_{CC} = +3\text{ V}$ | 0.12 | - | - | V/ns |
| Control inputs: pins CLKDIV1 and RSTIN[6] | | | | | | |
| V_{IL} | LOW-level input voltage | | -0.3 | - | $0.3V_{DD(INTF)}$ | V |
| V_{IH} | HIGH-level input voltage | | $0.7V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.3$ | V |
| V_{hys} | hysteresis voltage | control input | - | $0.14V_{DD(INTF)}$ | - | V |
| I_{IL} | LOW-level input current | $V_{IL} = 0\text{ V}$ | - | - | 1 | μA |
| I_{IH} | HIGH-level input current | $V_{IH} = V_{DD(INTF)}$ | - | - | 1 | μA |
| Control input: pin CMDVCCN[6] | | | | | | |
| V_{IL} | LOW-level input voltage | | -0.3 | - | $0.3V_{DD(INTF)}$ | V |
| V_{IH} | HIGH-level input voltage | | $0.7V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.3$ | V |
| V_{hys} | hysteresis voltage | control input | - | $0.14V_{DD(INTF)}$ | - | V |
| I_{IL} | LOW-level input current | $V_{IL} = 0\text{ V}$ | - | - | 1 | μA |
| I_{IH} | HIGH-level input current | $V_{IH} = V_{DD(INTF)}$ | - | - | 1 | μA |
| $f_{CMDVCCN}$ | frequency on pin CMDVCCN | | - | - | 100 | Hz |
| t_w | pulse width | 5 V card; Figure 10 | 30 | - | - | ms |
| | | 3 V card; Figure 11 , Figure 12 | - | - | 15 | ms |
| Card detection input[6][7] | | | | | | |
| V_{IL} | LOW-level input voltage | | -0.3 | - | $0.3V_{DD(INTF)}$ | V |

Table 7. Characteristics of IC supply voltage ...continued

$V_{DDP} = 5\text{ V}$; $V_{DD} = 3.3\text{ V}$; $V_{DD(INTF)} = 3.3\text{ V}$; $f_{xtal} = 10\text{ MHz}$; $GND = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-----------|--------------------------|--------------------------------------|-------------------|--------------------|----------------------|---------------|
| V_{IH} | HIGH-level input voltage | | $0.7V_{DD(INTF)}$ | - | $V_{DD(INTF)} + 0.3$ | V |
| V_{hys} | hysteresis voltage | pin PRESN | - | $0.14V_{DD(INTF)}$ | - | V |
| I_{IL} | LOW-level input current | $0\text{ V} < V_{IL} < V_{DD(INTF)}$ | - | - | 5 | μA |
| I_{IH} | HIGH-level input current | $0\text{ V} < V_{IH} < V_{DD(INTF)}$ | - | - | 5 | μA |

OFFN output[8]

| | | | | | | |
|----------|---------------------------|-----------------------------------|--------------------|----|-----|------------------|
| V_{OL} | LOW-level output voltage | $I_{OL} = 2\text{ mA}$ | 0 | - | 0.3 | V |
| V_{OH} | HIGH-level output voltage | $I_{OH} = -15\text{ }\mu\text{A}$ | $0.75V_{DD(INTF)}$ | - | - | V |
| R_{pu} | pull-up resistance | connected to $V_{DD(INTF)}$ | 16 | 20 | 24 | $\text{k}\Omega$ |

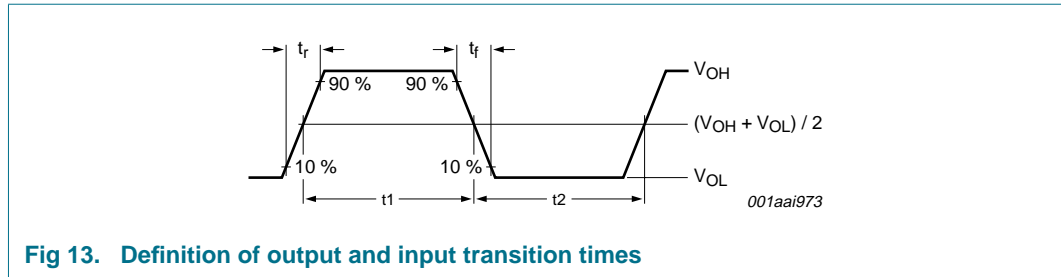
- [1] To meet these specifications, V_{CC} should be decoupled to pin GND using two ceramic multilayer capacitors of low ESR with values of either 100 nF or one 220 nF and one 470 nF.
- [2] Using decoupling capacitors of one 220 nF $\pm 20\%$ and one 470 nF $\pm 20\%$.
- [3] Using the integrated 9 $\text{k}\Omega$ pull-up resistor connected to V_{CC} .
- [4] Using the integrated 10 $\text{k}\Omega$ pull-up resistor connected to $V_{DD(INTF)}$.
- [5] The transition time and the duty factor definitions are shown in [Figure 13 on page 19](#); $\delta = t1 / (t1 + t2)$.
- [6] Pins PRESN and CMDVCCN are active LOW; pin RSTIN is active HIGH; see [Table 4](#) for states of pin CLKDIV1.
- [7] Pin PRESN has an integrated current source of 1.25 μA to $V_{DD(INTF)}$.
- [8] Pin OFFN is an NMOS drain, using an internal 20 $\text{k}\Omega$ pull-up resistor connected to $V_{DD(INTF)}$.

Table 8. Protection characteristics

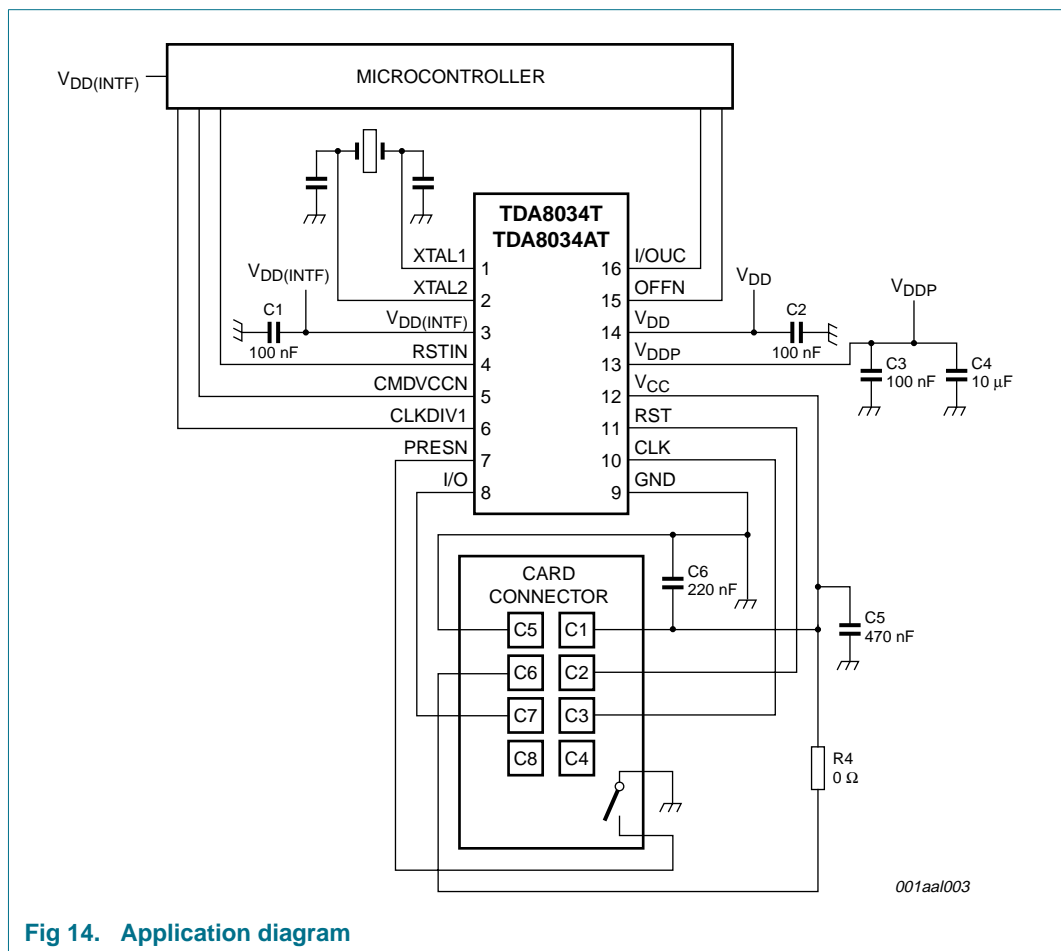
| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------|----------------------|--------------|-----|-----|-----|--------------------|
| I_{Olim} | output current limit | pin I/O | -15 | - | +15 | mA |
| | | pin V_{CC} | 135 | 175 | 225 | mA |
| | | pin CLK | -70 | - | +70 | mA |
| | | pin RST | -20 | - | +20 | mA |
| I_{sd} | shutdown current | pin V_{CC} | 90 | 120 | 150 | mA |
| T_{sd} | shutdown temperature | at die | - | 150 | - | $^{\circ}\text{C}$ |

Table 9. Timing characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-------------|-------------------|--|------|-----|------|---------------|
| t_{act} | activation time | see Figure 9 on page 12 | 2090 | - | 4160 | μs |
| t_{deact} | deactivation time | see Figure 7 on page 10 | 35 | 90 | 250 | μs |
| t_d | delay time | CLK sent to card using an external clock | | | | |
| | | $t_{d(start)} = t3$; see Figure 6 on page 9 | 2090 | - | 4112 | μs |
| | | $t_{d(end)} = t5$; see Figure 6 on page 9 | 2120 | - | 4160 | μs |
| t_{deb} | debounce time | pin PRESN | 3.2 | 4.5 | 6.4 | ms |



12. Application information



13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

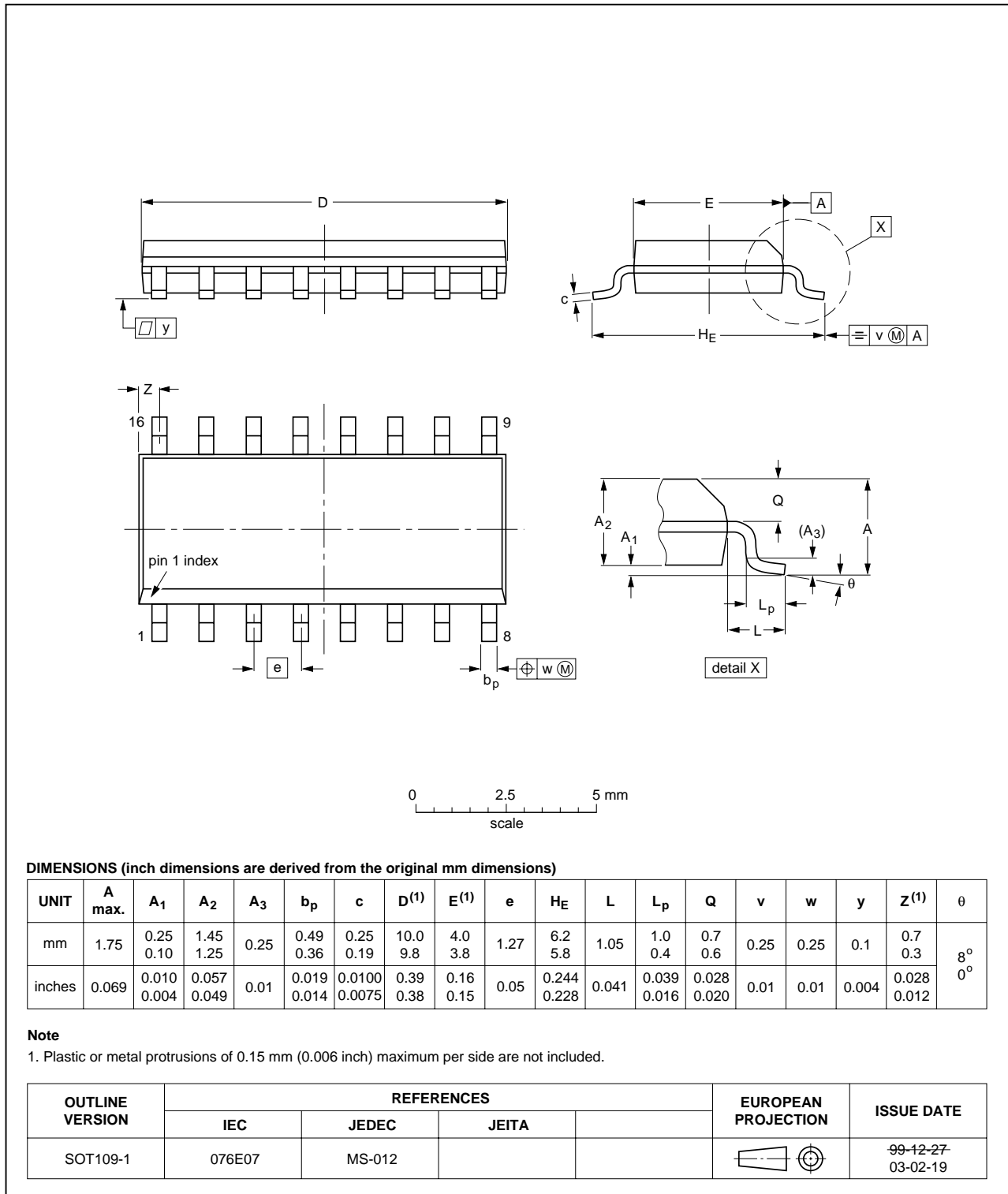


Fig 15. Package outline SOT109-1 (SO16)

14. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

14.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

14.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

14.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

14.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see [Figure 16](#)) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with [Table 10](#) and [11](#)

Table 10. SnPb eutectic process (from J-STD-020C)

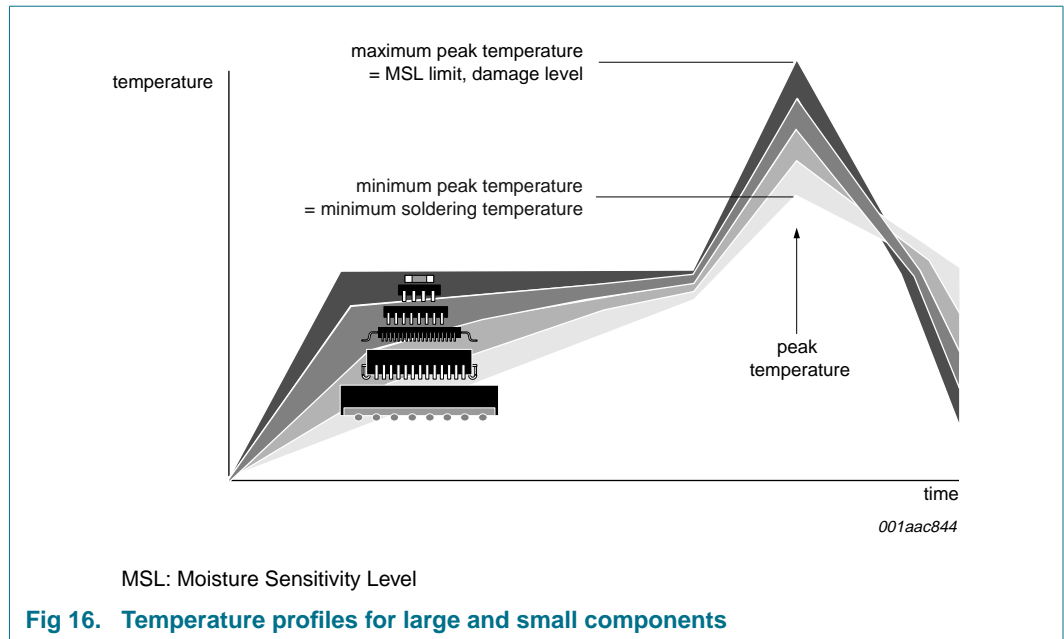
| Package thickness (mm) | Package reflow temperature (°C) | |
|------------------------|---------------------------------|-------|
| | Volume (mm ³) | |
| | < 350 | ≥ 350 |
| < 2.5 | 235 | 220 |
| ≥ 2.5 | 220 | 220 |

Table 11. Lead-free process (from J-STD-020C)

| Package thickness (mm) | Package reflow temperature (°C) | | |
|------------------------|---------------------------------|-------------|--------|
| | Volume (mm ³) | | |
| | < 350 | 350 to 2000 | > 2000 |
| < 1.6 | 260 | 260 | 260 |
| 1.6 to 2.5 | 260 | 250 | 245 |
| > 2.5 | 250 | 245 | 245 |

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see [Figure 16](#).



For further information on temperature profiles, refer to Application Note AN10365 “Surface mount reflow soldering description”.

15. Abbreviations

Table 12. Abbreviations

| Acronym | Description |
|---------|--|
| EMV | Europay MasterCard VISA |
| ESD | ElectroStatic Discharge |
| ESR | Equivalent Series Resistor |
| FCDM | Field Charged Device Model |
| HBM | Human Body Model |
| LDO | Low Drop-Out |
| MM | Machine Model |
| NMOS | Negative-channel Metal-Oxide Semiconductor |
| POR | Power-On Reset |

16. Revision history

Table 13. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------------|--------------|--------------------|---------------|------------|
| TDA8034T_TDA8034AT_1 | 20100205 | Product data sheet | - | - |

17. Legal information

17.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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19. Tables

| | | |
|-----------|---|----|
| Table 1. | Quick reference data | 2 |
| Table 2. | Ordering information | 2 |
| Table 3. | Pin description | 4 |
| Table 4. | Clock configuration | 7 |
| Table 5. | Limiting values | 13 |
| Table 6. | Thermal characteristics | 13 |
| Table 7. | Characteristics of IC supply voltage | 14 |
| Table 8. | Protection characteristics | 18 |
| Table 9. | Timing characteristics | 18 |
| Table 10. | SnPb eutectic process (from J-STD-020C) | 22 |
| Table 11. | Lead-free process (from J-STD-020C) | 22 |
| Table 12. | Abbreviations | 23 |
| Table 13. | Revision history | 24 |

20. Figures

| | | |
|---------|--|----|
| Fig 1. | Block diagram | 3 |
| Fig 2. | Pin configuration (SO16) | 4 |
| Fig 3. | Voltage supervisor circuit | 5 |
| Fig 4. | Voltage supervisor waveforms | 6 |
| Fig 5. | Basic layout for using an external clock | 7 |
| Fig 6. | Activation sequence at t3 | 9 |
| Fig 7. | Deactivation sequence | 10 |
| Fig 8. | Emergency deactivation sequence after card removal | 11 |
| Fig 9. | Operation of debounce feature with pins OFFN, CMDVCCN, PRESN and V _{CC} | 12 |
| Fig 10. | Card activation, V _{CC} = 5 V, t ₀ > 30 ms | 12 |
| Fig 11. | Card activation, V _{CC} = 3 V, t ₀ < 15 ms | 12 |
| Fig 12. | Card activation, V _{CC} = 3 V, t ₀ > 15 ms | 13 |
| Fig 13. | Definition of output and input transition times | 19 |
| Fig 14. | Application diagram | 19 |
| Fig 15. | Package outline SOT109-1 (SO16) | 20 |
| Fig 16. | Temperature profiles for large and small components | 23 |

21. Contents

| | | |
|-----------|--|-----------|
| 1 | General description | 1 |
| 2 | Features | 1 |
| 3 | Applications | 1 |
| 4 | Quick reference data | 2 |
| 5 | Ordering information | 2 |
| 6 | Block diagram | 3 |
| 7 | Pinning information | 4 |
| 7.1 | Pinning | 4 |
| 7.2 | Pin description | 4 |
| 8 | Functional description | 5 |
| 8.1 | Power supplies | 5 |
| 8.2 | Voltage supervisor | 5 |
| 8.3 | Clock circuits | 6 |
| 8.4 | Input and output circuits | 7 |
| 8.5 | Shutdown mode | 8 |
| 8.6 | Activation sequence | 8 |
| 8.7 | Deactivation sequence | 9 |
| 8.8 | V _{CC} regulator | 10 |
| 8.9 | Fault detection | 10 |
| 8.10 | Automatic determining of card supply voltage | 12 |
| 9 | Limiting values | 13 |
| 10 | Thermal characteristics | 13 |
| 11 | Characteristics | 14 |
| 12 | Application information | 19 |
| 13 | Package outline | 20 |
| 14 | Soldering of SMD packages | 21 |
| 14.1 | Introduction to soldering | 21 |
| 14.2 | Wave and reflow soldering | 21 |
| 14.3 | Wave soldering | 21 |
| 14.4 | Reflow soldering | 22 |
| 15 | Abbreviations | 23 |
| 16 | Revision history | 24 |
| 17 | Legal information | 25 |
| 17.1 | Data sheet status | 25 |
| 17.2 | Definitions | 25 |
| 17.3 | Disclaimers | 25 |
| 17.4 | Trademarks | 26 |
| 18 | Contact information | 26 |
| 19 | Tables | 27 |
| 20 | Figures | 28 |
| 21 | Contents | 29 |

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